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U.S. Dept. of Commerce, Patent and Trademarks Form PTO LIST OF ART CITED BY APPLICANT (Use several sheets if necessary Filing Date Attorney Docket No. Serial No. **AUGUST 7, 2001** A-7172 09/924,111 Applicant: Group GAUL ET AL. 2611 **U.S. PATENT DOCUMENTS** Class Exami Document No. Date Name **Subclass** ner's Initial AA ABJAN 2 9 2004 AC Technology Center 2600 AD ΑE FOREIGN PATENT DOCUMENTS Country **Translation** Document No. Date Class Subclass 25 AF WO 99/04560 28.01.99 PCT Int'l AG AH ΑI OTHER PRIOR ART (Including Author Title, Date, Pertinent Pages, Etc.) AJ AK AL DATE CONSIDERED: **EXAMINER** 3/3/2006 EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance. Include copy of this form with next communication to Applicant.

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Form PTO-1449 U.S. Dept. of Commerce, Patent and Trademarks LIST OF ART CITED BY APPLICANT (Use several sheets if necessary Attorney Docket No. Filing Date Serial No. 09/924,111 AUGUST 7, 2001 A-7172 Applicant: Group 2611 GAUL ET AL. **U.S. PATENT DOCUMENTS** Class Subclass Document No. Date Name Exami ner's Initial CS AA5,886,690 3/23/99 Pond et al. 345 327 CS 348 AB 5,978,043 11/2/99 Blonstein et al. 569 RECEIVED AC MPR 1 7 4003 AD Technology Center 2600 AE FOREIGN PATENT DOCUMENTS Document No. Subclass Translation Date Country Class AF AG AH ΑI OTHER PRIOR ART (Including Author Title, Date, Pertinent Pages, Etc.) ΑJ AK ΑL DATE CONSIDERED: **EXAMINER** 3/3/2006 EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance. Include copy of this form with next communication to Applicant.

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